N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY			
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)[a, e]	Q_g (Typ.)
30	0.015 at V_{GS} = 10 V	20	14nC
	0.019 at V_{GS} = 4.5 V	16	

FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

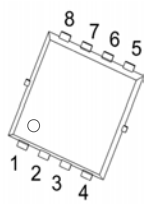
RoHS COMPLIANT

APPLICATIONS

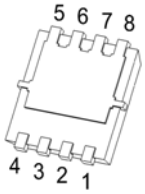
- Notebook PC Core
- VRM/POL

PDFN 3.3x3.3

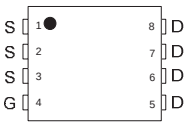
Top View

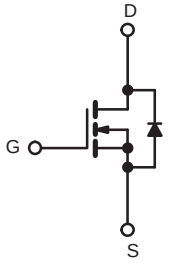


Bottom View



Top View





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)				
Parameter		**Symbol**	**Limit**	**Unit**
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current (T_J = 175 °C)	T_C = 25 °C	I_D	20[a, e]	A
	T_C = 70 °C		16[e]	
	T_A = 25 °C		15[b, c]	
	T_A = 70 °C		13[b, c]	
Pulsed Drain Current		I_{DM}	60	
Avalanche Current Pulse	L = 0.1 mH	I_{AS}	17	
Single Pulse Avalanche Energy		E_{AS}	16	mJ
Continuous Source-Drain Diode Current	T_C = 25 °C	I_S	18[a, e]	A
	T_A = 25 °C		13[b, c]	
Maximum Power Dissipation	T_C = 25 °C	P_D	16	W
	T_C = 70 °C		7	
	T_A = 25 °C		4.5[b, c]	
	T_A = 70 °C		2.6[b, c]	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS					
Parameter		**Symbol**	**Typical**	**Maximum**	**Unit**
Maximum Junction-to-Ambient[b, d]	t ≤ 10 s	R_{thJA}	31	44	°C/W
Maximum Junction-to-Case	Steady State	R_{thJC}	3	4	

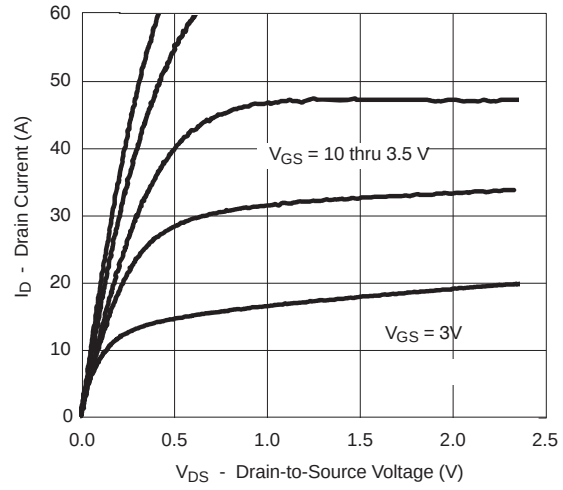
Notes:
a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.
c. t = 10 s.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)						
Parameter	**Symbol**	**Test Conditions**	**Min .**	**Typ.**	**Max.**	**Unit**
Static						
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0 V, I_D = 250 µA	30			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I_D = 250 µA		35		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.5		
Gate-Source Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250 µA	1		3	V
Gate-Source Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 24 V, V_{GS} = 0 V			1	µA
		V_{DS} = 24 V, V_{GS} = 0 V, T_J = 55 °C			10	
On-State Drain Current[a]	$I_{D(on)}$	$V_{DS} \geq$ 5 V, V_{GS} = 10 V	60			A
Drain-Source On-State Resistance[a]	$R_{DS(on)}$	V_{GS} = 10 V, I_D = 10 A		0.015	0.017	Ω
		V_{GS} = 4.5 V, I_D = 8 A		0.019	0.022	
Forward Transconductance[a]	g_{fs}	V_{DS} = 24 V, I_D = 10 A		35		S
Dynamic[b]						
Input Capacitance	C_{iss}	V_{DS}= 24V, V_{GS} = 0 V, f = 1 MHz		631		pF
Output Capacitance	C_{oss}			420		
Reverse Transfer Capacitance	C_{rss}			105		
Total Gate Charge	Q_g	V_{DS} = 24 V, V_{GS} = 10 V, I_D = 10 A		14		nC
		V_{DS} = 24 V, V_{GS} = 4.5 V, I_D = 8 A		6.5		
Gate-Source Charge	Q_{gs}			4		
Gate-Drain Charge	Q_{gd}			3		
Gate Resistance	R_g	f = 1 MHz		3	5	Ω
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 24 V, R_L = 1.8 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_g = 3 Ω		10		ns
Rise Time	t_r			8		
Turn-Off Delay Time	$t_{d(off)}$			21		
Fall Time	t_f			12		
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 24 V, R_L = 1.8 Ω $I_D \cong$ 8 A, V_{GEN} = 4.5 V, R_g = 3 Ω		20		
Rise Time	t_r			17		
Turn-Off Delay Time	$t_{d(off)}$			50		
Fall Time	t_f			15		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	T_C = 25 °C			18	A
Pulse Diode Forward Current[a]	I_{SM}				54	
Body Diode Voltage	V_{SD}	I_S = 10 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	I_F = 10 A, di/dt = 100 A/µs, T_J = 25 °C		10		ns
Body Diode Reverse Recovery Charge	Q_{rr}			15		nC
Reverse Recovery Fall Time	t_a			20		ns
Reverse Recovery Rise Time	t_b			22		

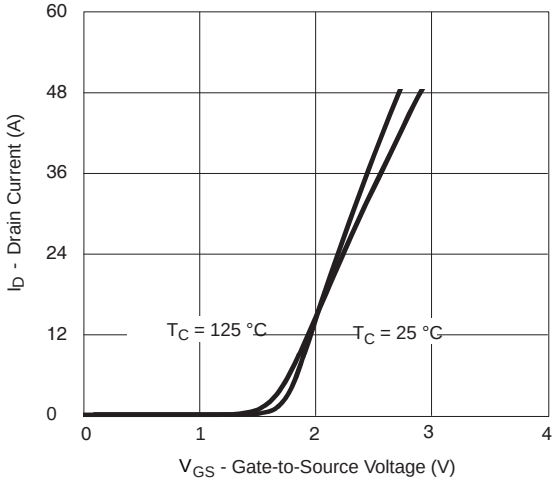
Notes:
a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

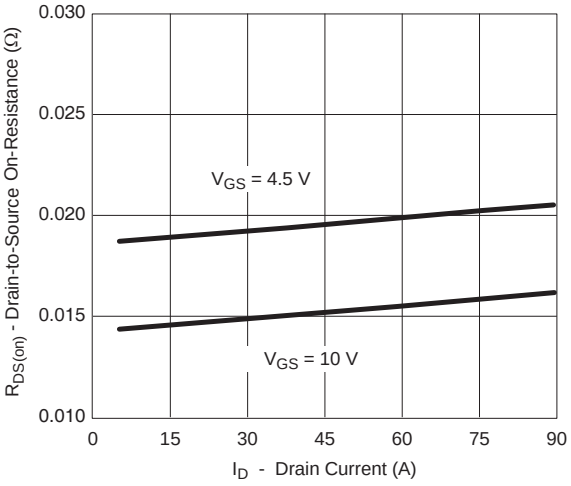
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



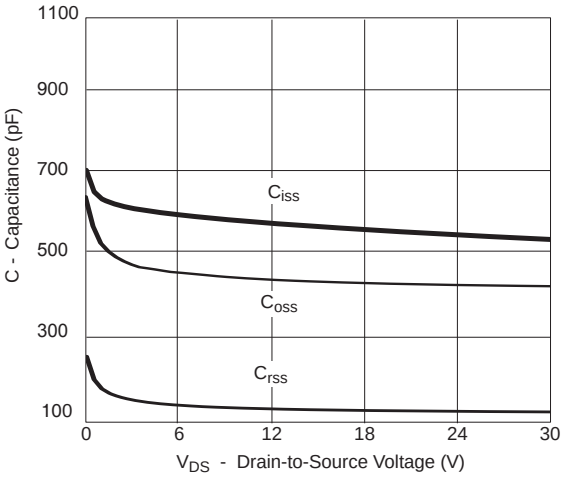
Output Characteristics



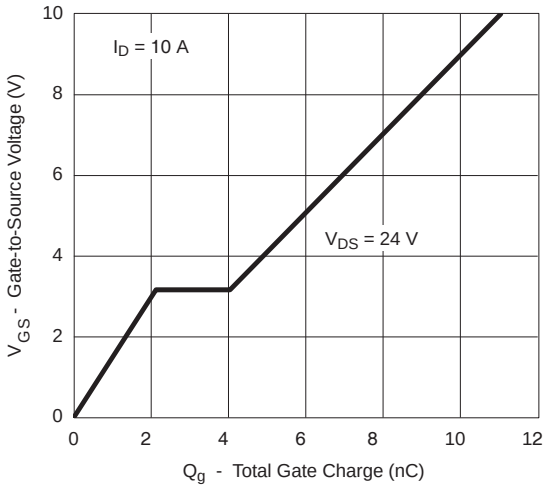
Transfer Characteristics



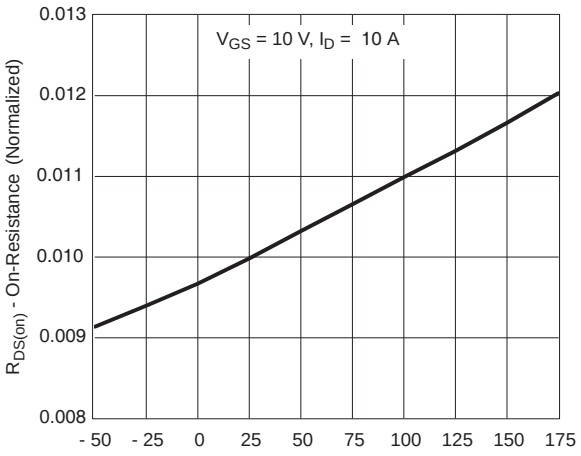
$R_{DS(on)}$ vs. Drain Current



Capacitance

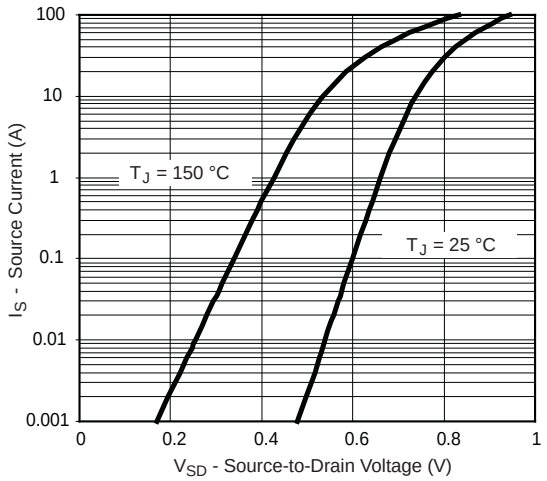


Gate Charge

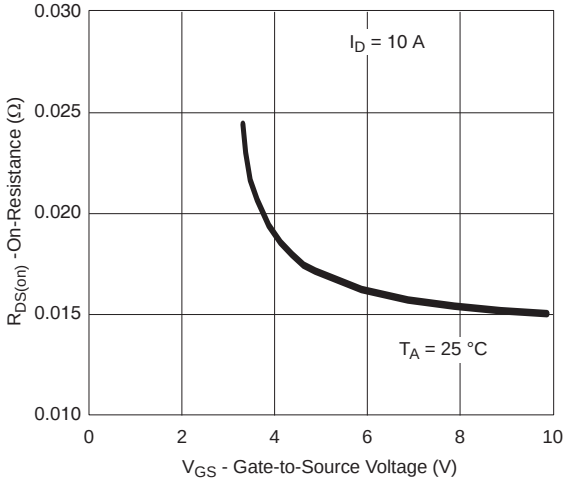


On-Resistance vs. Junction Temperature

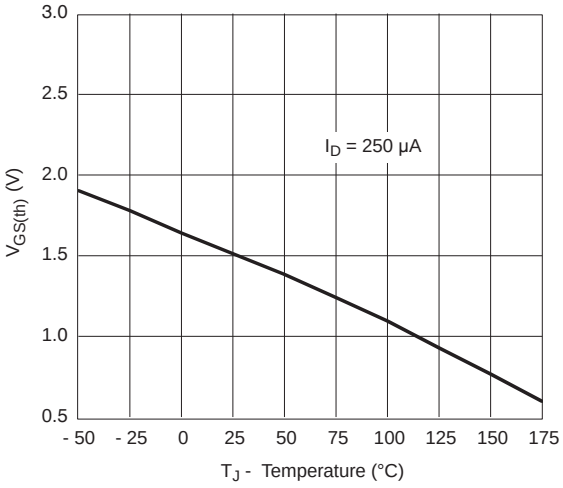
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



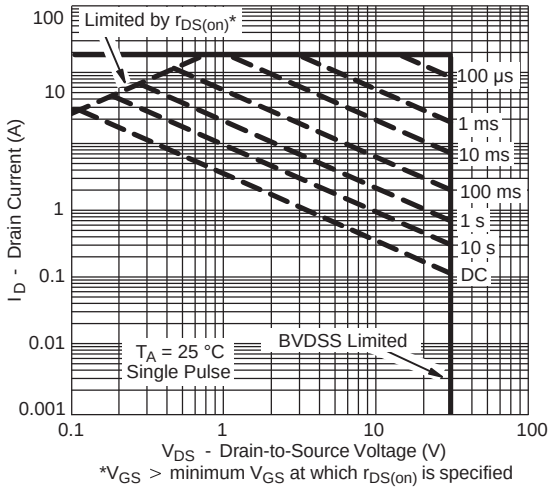
Forward Diode Voltage vs. Temperature



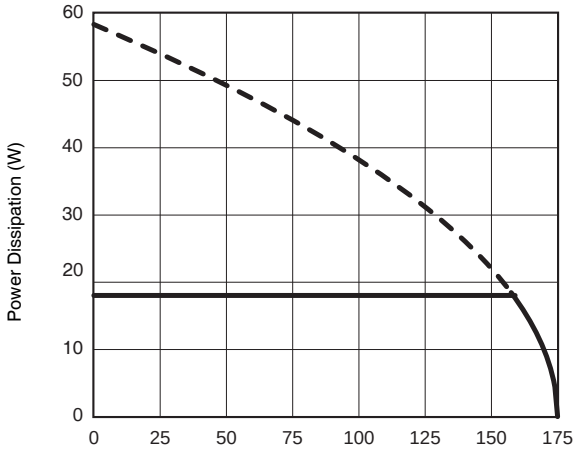
$R_{DS(on)}$ vs. V_{GS} vs. Temperature



Threshold Voltage

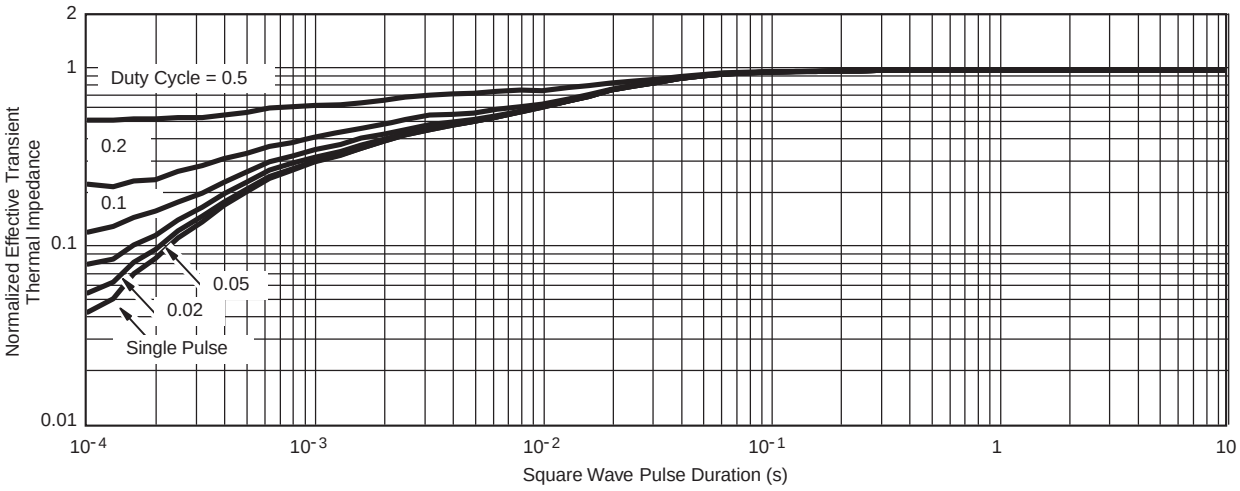


Safe Operating Area, Junction-to-Ambient



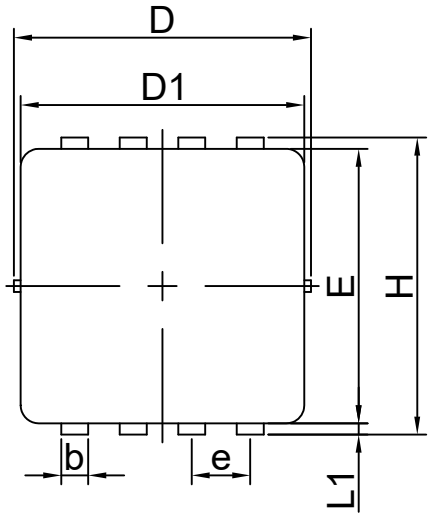
Power Derating

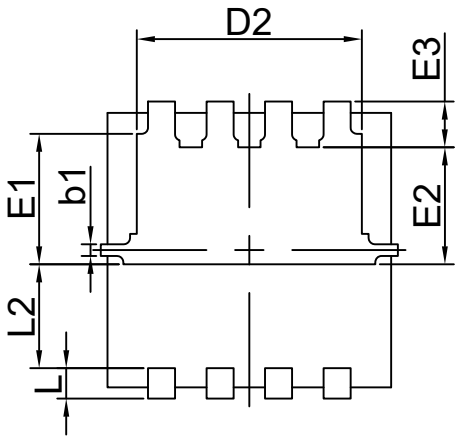
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

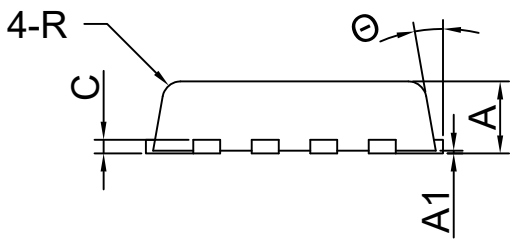


Normalized Thermal Transient Impedance, Junction-to-Case

PDFN3.3*3.3-8L Case Outline







SYMBOL	MIN	NOM	MAX
A	0.70	0.80	0.90
A_1	0.00	0.03	0.05
b	0.24	0.30	0.35
b1	0.08	0.13	0.18
c		0.152REF	
D	3.25	3.32	3.40
D1	3.05	3.15	3.25
D2	2.40	2.50	2.60
E	3.00	3.10	3.20
E1	1.35	1.45	1.55
E2	1.20	1.30	1.40
E3	0.40	0.50	0.60
e		0.65 BSC	
H	3.20	3.30	3.40
L	0.30	0.40	0.50
L1	0.10	0.15	0.20
L2		1.13 REF	
R		0.20 REF	
Θ	6°	10°	14°

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